

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>250564US2</b>		SERIAL NO. <b>10/801,822</b>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Hiroyuki KIMBARA, et al.</b>			
				FILING DATE <b>March 17, 2004</b>		GROUP <b>2167</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	US 2002/0046216 A1	4/18/2002	Tomotaka YAMAZAKI, et al			
	AB	US 2002/0116632 A1	8/22/2002	Shinji ITOH, et al.			
	AC	US 2002/0054326 A1	5/9/2002	Tetsuya MORITA			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES      NO		
	AO	2003-47781	2/18/2003	Japan (with English abstract)			x
	AP	2001-350657	12/21/2001	Japan (corr: US 2002/0046216 A1)			x
	AQ	2002-251326	9/6/2002	Japan (corr: US 2002/0116632 A1)			x
	AR	7-244584	9/19/1995	Japan (with English abstract)			x
	AS	WO 02/103495 A1	12/27/2002	WIPO			
	AT	2003-67336	3/7/2003	Japan (with English abstract)			x
	AU	2003-6397	1/10/2003	Japan (with English abstract)			x
	AV	6-243087	9/2/1994	Japan (with English abstract)			x
	AW	8-153048	6/11/1996	Japan (with English abstract)			x
	AX	2002-10044	1/11/2002	Japan (with English abstract)			x
	AY	2002-91744	3/29/2002	Japan (with English abstract)			x
	AZ	2002-82806	3/22/2002	Japan (corr: US 2002/0054326 A1)			
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	BA						
	BB						
	BC						
	BD					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							